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		10624489		VIERICH ET AL.	
Examiner		Lin, Shew-Fen		Art Unit 2166	
INTERNATIONAL CLASSIFICATION					
ORIGINAL			CLAIMED		
CLASS	CLASS	SUBCLASS	G 0 6 F	G 0 6 F	NON-CLAIMED
707	102		G 0 6 F	7/00	
CROSS REFERENCE(S)					
CLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)	G 0 6 F	G 0 6 F	3/00
715	854		G 0 6 F	9/00	
Shew-fen Lin (Assistant Examiner) (Legal Instruments Examiner)		2/16/2007 (Date)	Total Claims Allowed: 12		
G. White (Primary Examiner) (Legal Instruments Examiner)		2/24/07 (Date)	O.G. Print Claim(s) 12	O.G. Print Figure 1	

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